

RF TEST REPORT

For

Shenzhen Kunkun Technology Co.,Ltd. Product Name: Wireless Headphones

Test Model(s).: H06

Report Reference No. : DACE240829002RF001

FCC ID : 2A8UE-H06

Applicant's Name : Shenzhen Kunkun Technology Co.,Ltd.

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Test Specification Standard : 47 CFR Part 15.247

Date of Receipt : August 29, 2024

Date of Test : August 29, 2024 to September 12, 2024

Data of Issue : September 14, 2024

Result : Pass

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Revision History Of Report

Version	Description	REPORT No.	Issue Date
V1.0	Original	DACE240829002RF001	September 14, 2024
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NOTE1:

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards.

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1 TEST SUMMARY

1.1 Test Standards

The tests were performed according to following standards:

47 CFR Part 15.247: Operation within the bands 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz

1.2 Summary of Test Result

Item	Standard	Method	Requirement	Result
Antenna requirement	47 CFR Part 15.247		47 CFR 15.203	Pass
Conducted Emission at AC power line	47 CFR Part 15.247	ANSI C63.10-2013 section 6.2	47 CFR 15.207(a)	Pass
Occupied Bandwidth	47 CFR Part 15.247	ANSI C63.10-2013, section 7.8.7 KDB 558074 D01 15.247 Meas Guidance v05r02	47 CFR 15.247(a)(1)	Pass
Maximum Conducted Output Power	47 CFR Part 15.247	ANSI C63.10-2013, section 7.8.5 KDB 558074 D01 15.247 Meas Guidance v05r02	47 CFR 15.247(b)(1)	Pass
Channel Separation	47 CFR Part 15.247	ANSI C63.10-2013, section 7.8.2 KDB 558074 D01 15.247 Meas Guidance v05r02	47 CFR 15.247(a)(1)	Pass
Number of Hopping Frequencies	47 CFR Part 15.247	ANSI C63.10-2013, section 7.8.3 KDB 558074 D01 15.247 Meas Guidance v05r02	47 CFR 15.247(a)(1)(iii)	Pass
Dwell Time	47 CFR Part 15.247	ANSI C63.10-2013, section 7.8.4 KDB 558074 D01 15.247 Meas Guidance v05r02	47 CFR 15.247(a)(1)(iii)	Pass
Emissions in non-restricted frequency bands	47 CFR Part 15.247	ANSI C63.10-2013 section 7.8.8 KDB 558074 D01 15.247 Meas Guidance v05r02	47 CFR 15.247(d), 15.209, 15.205	Pass
Band edge emissions (Radiated)	47 CFR Part 15.247	ANSI C63.10-2013 section 6.10 KDB 558074 D01 15.247 Meas Guidance v05r02	47 CFR 15.247(d), 15.209, 15.205	Pass
Emissions in frequency bands (below 1GHz)	47 CFR Part 15.247	ANSI C63.10-2013 section 6.6.4 KDB 558074 D01 15.247 Meas Guidance v05r02	47 CFR 15.247(d), 15.209, 15.205	Pass
Emissions in frequency bands (above 1GHz)	47 CFR Part 15.247	ANSI C63.10-2013 section 6.6.4 KDB 558074 D01 15.247 Meas Guidance v05r02	47 CFR 15.247(d), 15.209, 15.205	Pass

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2 GENERAL INFORMATION

2.1 Client Information

Applicant's Name: Shenzhen Kunkun Technology Co.,Ltd.

Address : B202# Block B, Wenle Industrial Zone, Longzhu, Xixiang, Bao'an District,

Shenzhen, China

Manufacturer : Shenzhen H-Sound Technology Co., Ltd.

Address : 506# Block C, Wenle Industrial Zone, Longzhu, Xixiang, Bao'an District,

Shenzhen, China

2.2 Description of Device (EUT)

Product Name:	Wireless Headphones
Model/Type reference:	H06
Series Model:	A3,i6,H03,H07,H08,H09,H10,H12,A24,H11,H12,H13,H15,H16,H18,H19,H20,H 21,H22
Model Difference:	The product has many models, only the model name is different, and the other parts such as the circuit principle, pcb and electrical structure are the same.
Trade Mark:	Hmusic
Power Supply:	DC 5V/1A from adapter Battery:DC3.7V 270mAh
Operation Frequency:	2402MHz to 2480MHz
Number of Channels:	79
Modulation Type:	GFSK, π/4 DQPSK, 8DPSK
Antenna Type:	PCB
Antenna Gain:	0dBi
Hardware Version:	V1.0
Software Version:	V1.0

(Remark:The Antenna Gain is supplied by the customer.DACE is not responsible for This data and the related calculations associated with it)

Operation Frequency each of channel							
Channel	Frequency	Channel	Frequency	Channel	Frequency	Channel	Frequency
1	2402MHz	21	2422MHz	41	2442MHz	61	2462MHz
2	2403MHz	22	2423MHz	42	2443MHz	62	2463MHz
3	2404MHz	23	2424MHz	43	2444MHz	63	2464MHz
4	2405MHz	24	2425MHz	44	2445MHz	64	2465MHz
5	2406MHz	25	2426MHz	45	2446MHz	65	2466MHz
6	2407MHz	26	2427MHz	46	2447MHz	66	2467MHz
7	2408MHz	27	2428MHz	47	2448MHz	67	2468MHz
8	2409MHz	28	2429MHz	48	2449MHz	68	2469MHz
9	2410MHz	29	2430MHz	49	2450MHz	69	2470MHz
10	2411MHz	30	2431MHz	50	2451MHz	70	2471MHz
11	2412MHz	31	2432MHz	51	2452MHz	71	2472MHz
12	2413MHz	32	2433MHz	52	2453MHz	72	2473MHz

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13	2414MHz	33	2434MHz	53	2454MHz	73	2474MHz
14	2415MHz	34	2435MHz	54	2455MHz	74	2475MHz
15	2416MHz	35	2436MHz	55	2456MHz	75	2476MHz
16	2417MHz	36	2437MHz	56	2457MHz	76	2477MHz
17	2418MHz	37	2438MHz	57	2458MHz	77	2478MHz
18	2419MHz	38	2439MHz	58	2459MHz	78	2479MHz
19	2420MHz	39	2440MHz	59	2460MHz	79	2480MHz
20	2421MHz	40	2441MHz	60	2461MHz		10

In section 15.31(m), regards to the operating frequency range over 10 MHz, the Lowest frequency, the middle frequency, and the highest frequency of channel were selected to perform the test, and the selected channel see

To at also and	Frequency (MHz)
Test channel	BDR/EDR
Lowest channel	2402MHz
Middle channel	2441MHz
Highest channel	2480MHz

2.3 Description of Test Modes

No	Title	Description			
TM1	TX-GFSK (Non- Hopping)	Keep the EUT in continuously transmitting mode (non-hopping) with GFSK modulation.			
TM2	TX-Pi/4DQPSK (Non- Hopping)	Keep the EUT in continuously transmitting mode (non-hopping) with Pi/4DQPSK modulation.			
TM3	TX-GFSK (Hopping)	Keep the EUT in continuously transmitting mode (hopping) with GFSK modulation,.			
TM4	TX-Pi/4DQPSK (Hopping)	Keep the EUT in continuously transmitting mode (hopping) with Pi/4DQPSK modulation.			
Remark:Only the data of the worst mode would be recorded in this report.					

2.4 Description of Support Units

Title	Manufacturer	Model No.	Serial No.
AC-DC adapter	HUAWEI TECHNOLOGY	HW100400C01	

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2.5 Equipments Used During The Test

	A 1 77						
Conducted Emission at AC power line							
Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date			
SCHWARZ BECK	MESS- ELEKTRONIK	1	2024-03-25	2025-03-24			
SCHWARZ BECK	CAT5 8158	CAT5 8158#207	1	1			
SCHWARZ BECK	104	1	2024-03-20	2025-03-19			
SCHWARZ BECK	VTSD 9561-F Pulse limiter 10dB Ateennator	561-G071	2023-12-12	2024-12-11			
Anritsu	MP59B	M20531	1	/			
Rohde & Schwarz	ESPI TEST RECEIVER	ID:1164.6607K 03-102109- MH	2024-06-12	2025-06-11			
R&S	ESH3-Z5	831.5518.52	2023-12-12	2024-12-11			
SCHWARZ BECK	NSLK 8126	05055	2024-06-14	2025-06-13			
CYBERTEK	EM5010A	1	2023-09-27	2024-09-26			
EZ -EMC	EZ	V1.1.42	1	1			
	Manufacturer SCHWARZ BECK SCHWARZ BECK SCHWARZ BECK SCHWARZ BECK Anritsu Rohde & Schwarz R&S SCHWARZ BECK CYBERTEK	Manufacturer SCHWARZ BECK VTSD 9561-F Pulse limiter 10dB Ateennator Anritsu MP59B Rohde & ESPI TEST RECEIVER R&S SCHWARZ BECK NSLK 8126 CYBERTEK EM5010A	Manufacturer Model No Inventory No SCHWARZ BECK MESS- ELEKTRONIK / SCHWARZ BECK CAT5 8158 CAT5 8158#207 SCHWARZ BECK / / SCHWARZ BECK VTSD 9561-F Pulse limiter 10dB Ateennator 561-G071 Anritsu MP59B M20531 Rohde & Schwarz ESPI TEST RECEIVER ID:1164.6607K 03-102109- MH R&S ESH3-Z5 831.5518.52 SCHWARZ BECK NSLK 8126 05055 CYBERTEK EM5010A /	Manufacturer Model No Inventory No Cal Date SCHWARZ BECK MESS- ELEKTRONIK / 2024-03-25 SCHWARZ BECK CAT5 8158 CAT5 8158#207 / SCHWARZ BECK / 2024-03-20 SCHWARZ BECK VTSD 9561-F Pulse limiter 10dB Ateennator 561-G071 2023-12-12 Anritsu MP59B M20531 / Rohde & Schwarz ESPI TEST RECEIVER ID:1164.6607K 03-102109- MH 2024-06-12 R&S ESH3-Z5 831.5518.52 2023-12-12 SCHWARZ BECK NSLK 8126 05055 2024-06-14 CYBERTEK EM5010A / 2023-09-27			

Report No.: DACE240829002RF001

Maximum Conducted Output Power

Channel Separation

Number of Hopping Frequencies

Dwell Time

Emissions in non-restricted frequency bands

Occupied Bandwidth

Equipment	Manufacturer	facturer Model No		Cal Date	Cal Due Date
RF Test Software	TACHOY RTS-01		V1.0.0	1	1
High Pass filter	ZHINAN	OQHPF1-M1.5- 18G-224	6210075	1	
Power divider	MIDEWEST	PWD-2533	SMA-79	2023-05-11	2026-05-10
RF Sensor Unit	Tachoy Information Technology(she nzhen) Co.,Ltd.	TR1029-2	000001	/	/
Wideband radio communication tester	R&S	CMW500	113410	2024-06-12	2025-06-11
Signal Generator	Keysight	N5181A	MY48180415	2023-11-09	2024-11-08
Signal Generator	Keysight	N5182A	MY50143455	2023-11-09	2024-11-08
Spectrum Analyzer	Keysight	N9020A	MY53420323	2023-12-12	2024-12-11

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Band edge emissions (Radiated)
Emissions in frequency bands (below 1GHz)
Emissions in frequency bands (above 1GHz)

Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
EMI Test software	Farad	EZ -EMC	V1.1.42	1	1
Positioning Controller	3 /	MF-7802	<u>e</u> 1	1	/
High Pass filter	ZHINAN	OQHPF1-M1.5- 18G-224	6210075	1	7/6
Amplifier(18-40G)	COM-POWER	AH-1840	10100008-1	2022-04-05	2025-04-04
Horn antenna	COM-POWER	AH-1840 (18-40G)	10100008	2023-04-05	2025-04-04
Loop antenna	ZHINAN	ZN30900C	ZN30900C	2024-06-14	2026-06-13
Cable(LF)#2	Schwarzbeck	1	1.6	2024-02-19	2025-02-18
Cable(LF)#1	Schwarzbeck	1		2024-02-19	2025-02-18
Cable(HF)#2	Schwarzbeck	AK9515E	96250	2024-03-20	2025-03-19
Cable(HF)#1	Schwarzbeck	SYV-50-3-1	/	2024-03-20	2025-03-19
Power amplifier(LF)	Schwarzbeck	BBV9743	9743-151	2024-06-12	2025-06-11
Power amplifier(HF)	Schwarzbeck	BBV9718	9718-282	2024-06-12	2025-06-11
Wideband radio communication tester	R&S	CMW500	113410	2024-06-12	2025-06-11
Spectrum Analyzer	R&S	FSP30	1321.3008K40 -101729-jR	2024-06-12	2025-06-11
Horn Antenna	Sunol Sciences	DRH-118	A091114	2023-05-13	2025-05-12
Broadband Antenna	Sunol Sciences	JB6 Antenna	A090414	2023-05-21	2025-05-20

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2.6 Statement Of The Measurement Uncertainty

Test Item		Measurement Uncertainty
Conducted Disturbance (0.15~30MHz)	V	±3.41dB
Occupied Bandwidth		±3.63%
RF conducted power		±0.733dB
Duty cycle		±3.1%
Conducted Spurious emissions		±1.98dB
Radiated Emission (Above 1GHz)	J	±5.46dB
Radiated Emission (Below 1GHz)		±5.79dB
N ((A) TI () ()		

Note: (1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

2.7 Identification of Testing Laboratory

Company Name:	Shenzhen DACE Testing Technology Co., Ltd.
Address:	102 Building H1 & 1/F., Building H, Hongfa Science & Technology Park, Tangtou, Shiyan, Baoʻ an District, Shenzhen, Guangdong, China
Phone Number:	+86-13267178997
Fax Number:	86-755-29113252

Identification of the Responsible Testing Location

Company Name:	Shenzhen DACE Testing Technology Co., Ltd.					
Address:	Address: 102 Building H1 & 1/F., Building H, Hongfa Science & Technology Park, Tangtou, Shiyan, Bao' an District, Shenzhen, Guangdong, China					
Phone Number:	+86-13267178997					
Fax Number:	86-755-29113252					
FCC Registration Number:	0032847402					
Designation Number:	CN1342					
Test Firm Registration Number:	778666					
A2LA Certificate Number:	6270.01					

2.8 Announcement

- (1) The test report reference to the report template version v0.
- (2) The test report is invalid if not marked with the signatures of the persons responsible for preparing, reviewing and approving the test report.
- (3) The test report is invalid if there is any evidence and/or falsification.
- (4) This document may not be altered or revised in any way unless done so by POCE and all revisions are duly noted in the revisions section.
- (5) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.
- (6) The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.

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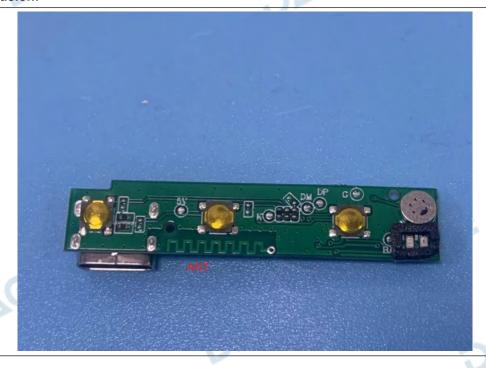
3 Evaluation Results (Evaluation)

3.1 Antenna requirement

Test Requirement:

Refer to 47 CFR Part 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section.

3.1.1 Conclusion:



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Radio Spectrum Matter Test Results (RF)

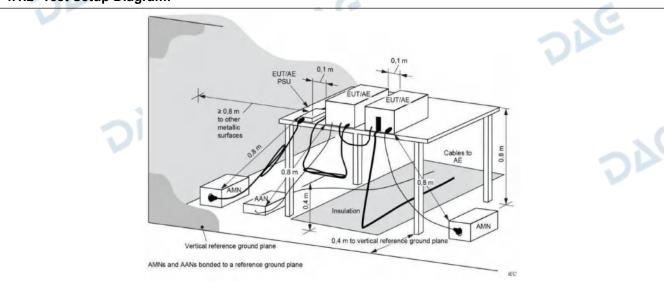
4.1 Conducted Emission at AC power line

Test Requirement:	Refer to 47 CFR 15.207(a), Except as shown in paragraphs (b)and (c)of this section, for an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies, within the band 150 kHz to 30 MHz, shall not exceed the limits in the following table, as measured using a 50 µH/50 ohms line impedance stabilization network (LISN).							
Test Limit:	Frequency of emission (MHz) Conducted limit (dBµV)							
		Quasi-peak	Average					
	0.15-0.5	66 to 56*	56 to 46*					
	0.5-5	56	46					
	5-30 60 50 *Decreases with the logarithm of the frequency.							
\								
Test Method:	ANSI C63.10-2013 section 6.2							
Procedure:	Refer to ANSI C63.10-2013 section 6.2, standard test method for ac power-line conducted emissions from unlicensed wireless devices							

4.1.1 E.U.T. Operation:

Operating Environment:								
Temperature: 22.3 °C			Humidity:	47 %		Atmospheric Pressure:	102 kPa	
Pretest mode: TM1,			TM2					
Final test mode:		TM1,	TM2					

4.1.2 Test Setup Diagram:

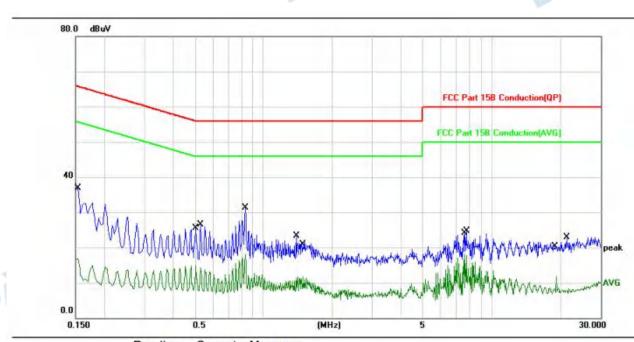


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4.1.3 Test Data:

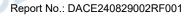
TM1 / Line: Line / Band: 2400-2483.5 MHz / BW: 1 / CH: L Power:AC120V60Hz



No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over			
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment	
1		0.1539	26.72	10.10	36.82	65.78	-28.96	QP		
2		0.1539	6.85	10.10	16.95	55.78	-38.83	AVG		
3		0.5060	4.87	10.08	14.95	46.00	-31.05	AVG		
4		0.5299	16.45	10.08	26.53	56.00	-29.47	QP		
5	*	0.8340	21.18	10.08	31.26	56.00	-24.74	QP		
6		0.8340	7.97	10.08	18.05	46.00	-27.95	AVG		
7		1.3900	13.27	10.05	23.32	56.00	-32.68	QP		
8		1.4900	1.69	10.04	11.73	46.00	-34.27	AVG		
9		7.6420	7.85	10.25	18.10	50.00	-31.90	AVG		
10		7.7540	14.35	10.27	24.62	60.00	-35.38	QP		
11		19.2099	1.38	10.57	11.95	50.00	-38.05	AVG		
12		21.3460	12.17	10.66	22.83	60.00	-37.17	QP		

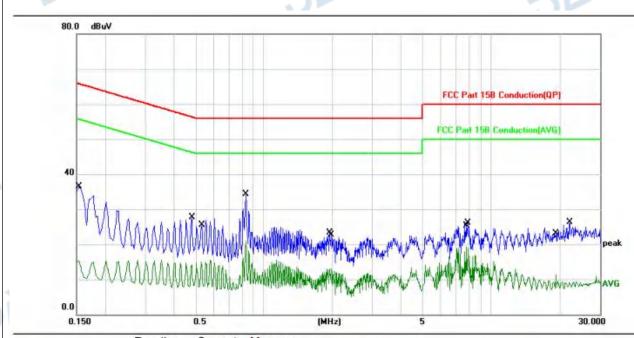
102, Building H1, & 1/F., Building H, Hongfa Science & Technology Park, Tangtou Connunity, Shiyan Subdistrict, Bao'an District, Shenzhen, Guangdong, China

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TM1 / Line: Neutral / Band: 2400-2483.5 MHz / BW: 1 / CH: L Power:AC120V60Hz



No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over			
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment	
1		0.1539	26.35	10.10	36.45	65.78	-29.33	QP		
2		0.1539	5.19	10.10	15.29	55.78	-40.49	AVG		
3		0.4820	17.60	10.08	27.68	56.30	-28.62	QP		
4		0.5299	5.01	10.08	15.09	46.00	-30.91	AVG		
5	*	0.8340	24.15	10.08	34.23	56.00	-21.77	QP		
6		0.8340	10.80	10.08	20.88	46.00	-25.12	AVG		
7		1.9460	13.25	10.00	23.25	56.00	-32.75	QP		
8		1.9700	3.15	9.99	13.14	46.00	-32.86	AVG		
9		7.7460	8.95	10.26	19.21	50.00	-30.79	AVG		
10		7.8620	15.79	10.27	26.06	60.00	-33.94	QP		
11		19.2099	0.81	10.57	11.38	50.00	-38.62	AVG		
12		22.1420	15.58	10.69	26.27	60.00	-33.73	QP		

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4.2 Occupied Bandwidth

4.2 Occupied Bandy	/idth	
Test Requirement:	47 CFR 15.247(a)(1)	2/6
Test Limit:	Refer to 47 CFR 15.215(c), intentional radiators open provisions to the general emission limits, as contain and in subpart E of this part, must be designed to expect of the emission, or whatever bandwidth may otherwork rule section under which the equipment operates, is band designated in the rule section under which the	ned in §§ 15.217 through 15.257 insure that the 20 dB bandwidth vise be specified in the specific scontained within the frequency
Test Method:	ANSI C63.10-2013, section 7.8.7, For occupied bar procedure in 6.9.2. KDB 558074 D01 15.247 Meas Guidance v05r02	ndwidth measurements, use the
Procedure:	a) The spectrum analyzer center frequency is set to center frequency. The span range for the EMI receive be between two times and five times the OBW. b) The nominal IF filter bandwidth (3 dB RBW) shall the OBW and video bandwidth (VBW) shall be apprunless otherwise specified by the applicable require c) Set the reference level of the instrument as requi	ver or spectrum analyzer shall I be in the range of 1% to 5% of roximately three times RBW, ement.
VE.	exceeding the maximum input mixer level for linear of the spectral envelope shall be more than [10 log reference level. Specific guidance is given in 4.1.5.2 d) Steps a) through c) might require iteration to adjutolerances.	operation. In general, the peak (OBW/RBW)] below the 2. ust within the specified
DIE	e) The dynamic range of the instrument at the select dB below the target "-xx dB down" requirement; that measuring the -20 dB OBW, the instrument noise flow at least 30 dB below the reference value. f) Set detection mode to peak and trace mode to make g) Determine the reference value: Set the EUT to train the reference value of the selection mode to peak and trace mode to make g).	at is, if the requirement calls for loor at the selected RBW shall ax hold.
	or modulated signal, as applicable. Allow the trace to analyzer marker to the highest level of the displayed value). h) Determine the "-xx dB down amplitude" using [(rx Alternatively, this calculation may be made by using instrument.	to stabilize. Set the spectrum d trace (this is the reference reference value) – xx]. g the marker-delta function of the
DP	i) If the reference value is determined by an unmode modulation ON, and either clear the existing trace of spectrum analyzer and allow the new trace to stabil step g) shall be used for step j). j) Place two markers, one at the lowest frequency a frequency of the envelope of the spectral display, su	or start a new trace on the lize. Otherwise, the trace from and the other at the highest
	slightly below the "-xx dB down amplitude" determine below this "-xx dB down amplitude" value, then it shall this value. The occupied bandwidth is the frequency markers. Alternatively, set a marker at the lowest frespectral display, such that the marker is at or slightly amplitude" determined in step h). Reset the marker marker to the other side of the emission until the de	ned in step h). If a marker is hall be as close as possible to y difference between the two equency of the envelope of the y below the "-xx dB down delta function and move the
DIE	same level as the reference marker amplitude. The at this point is the specified emission bandwidth. k) The occupied bandwidth shall be reported by pro instrument display; the plot axes and the scale units labeled. Tabular data may be reported in addition to	marker-delta frequency reading oviding plot(s) of the measuring sper division shall be clearly

Report No.: DACE240829002RF001

4.2.1 E.U.T. Operation:

	Environment:

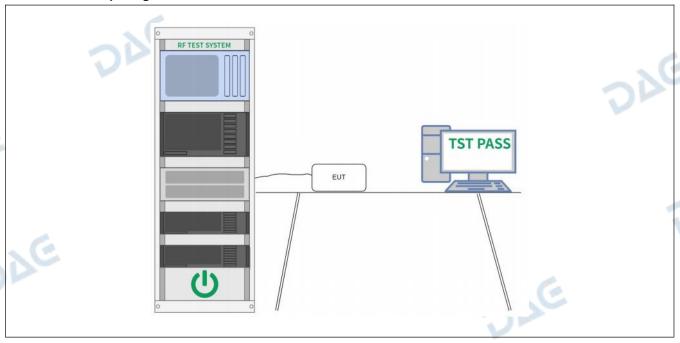
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Temperature: 22.3 °C	Humidity:	47 %	Atmospheric Pressure:	102 kPa
Pretest mode:	TM1, TM2	270		276
Final test mode:	TM1, TM2	V		J

4.2.2 Test Setup Diagram:



4.2.3 Test Data:

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4.3 Maximum Conducted Output Power

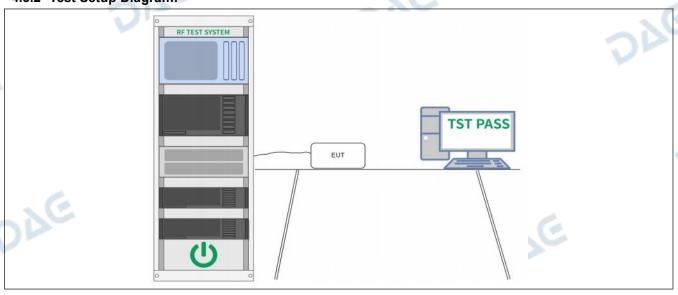
V1.0

Test Requirement:	47 CFR 15.247(b)(1)
Test Limit:	Refer to 47 CFR 15.247(b)(1), For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts.
Test Method:	ANSI C63.10-2013, section 7.8.5 KDB 558074 D01 15.247 Meas Guidance v05r02
Procedure:	This is an RF-conducted test to evaluate maximum peak output power. Use a direct connection between the antenna port of the unlicensed wireless device and the spectrum analyzer, through suitable attenuation. The hopping shall be disabled for this test: a) Use the following spectrum analyzer settings: 1) Span: Approximately five times the 20 dB bandwidth, centered on a hopping channel. 2) RBW > 20 dB bandwidth of the emission being measured.
ise ise	 3) VBW >= RBW. 4) Sweep: Auto. 5) Detector function: Peak. 6) Trace: Max hold. b) Allow trace to stabilize. c) Use the marker-to-peak function to set the marker to the peak of the emission. d) The indicated level is the peak output power, after any corrections for external attenuators and cables. e) A plot of the test results and setup description shall be included in the test report. NOTE—A peak responding power meter may be used, where the power meter and sensor system video bandwidth is greater than the occupied bandwidth of the unlicensed wireless device, rather than a spectrum analyzer.
4.3.1 E.U.T. Operation:	AE G

4.3.1 E.U.T. Operation:

Operating Environment:							
Temperature:	22.3 °C		Humidity:	47 %	Atmospheric Pressure:	102 kPa	
Pretest mode: TM1, 7			TM2				
Final test mode:		TM1,	TM2				

4.3.2 Test Setup Diagram:



4.3.3 Test Data:

Please Refer to Appendix for Details.

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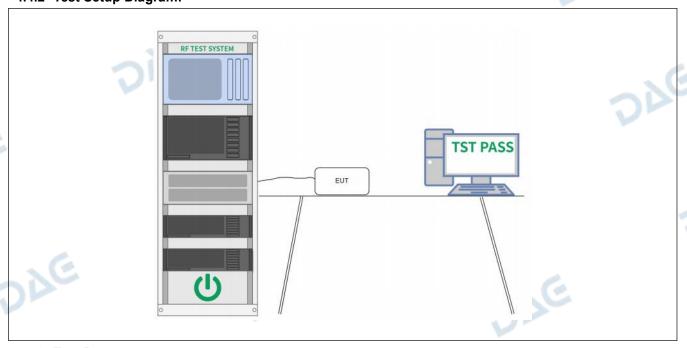
4.4 Channel Separation

Test Requirement:	47 CFR 15.247(a)(1)
Test Limit:	Refer to 47 CFR 15.247(a)(1), Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.
Test Method:	ANSI C63.10-2013, section 7.8.2 KDB 558074 D01 15.247 Meas Guidance v05r02
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Wide enough to capture the peaks of two adjacent channels. b) RBW: Start with the RBW set to approximately 30% of the channel spacing; adjust as necessary to best identify the center of each individual channel. c) Video (or average) bandwidth (VBW) ≥ RBW.
16	d) Sweep: Auto. e) Detector function: Peak. f) Trace: Max hold. g) Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels. Compliance of an EUT with the appropriate regulatory limit shall be determined. A plot of the data shall be included in the test report.

4.4.1 E.U.T. Operation:

Operating Environment:							
Temperature: 22.3 °C		Humidity:	47 %		Atmospheric Pressure:	102 kPa	
Pretest mode: TM3		TM3,	TM4	- 3	C		. 6
Final test mode		TM3,	TM4	OP			200

4.4.2 Test Setup Diagram:



4.4.3 Test Data:

Please Refer to Appendix for Details.

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4.5 Number of Hopping Frequencies

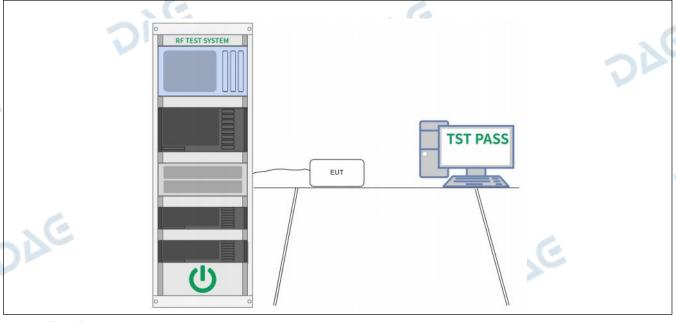
V1.0

ne mamber en mepp	0 1
Test Requirement:	47 CFR 15.247(a)(1)(iii)
Test Limit:	Refer to 47 CFR 15.247(a)(1)(iii), Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Method:	ANSI C63.10-2013, section 7.8.3 KDB 558074 D01 15.247 Meas Guidance v05r02
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: The frequency band of operation. Depending on the number of channels the device supports, it may be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen. b) RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller. c) VBW ≥ RBW. d) Sweep: Auto. e) Detector function: Peak. f) Trace: Max hold. g) Allow the trace to stabilize. It might prove necessary to break the span up into subranges to show clearly all of the hopping frequencies. Compliance of an EUT with the appropriate regulatory limit shall be determined for the number of hopping channels. A plot of the data shall be included in the test report.

4.5.1 E.U.T. Operation:

Operating Environment:							
Temperature:	22.3 °C		Humidity:	47 %	70	Atmospheric Pressure:	102 kPa
Pretest mode: TM3, TM4			200				
Final test mode: TM3, TM4							

4.5.2 Test Setup Diagram:



4.5.3 Test Data:

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4.6 Dwell Time

Test Requirement: 47 CFR 15.247(a)(1)(iii) Refer to 47 CFR 15.247(a)(1)(iii), Frequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used. Test Method: ANSI C63.10-2013, section 7.8.4 KDB 558074 D01 15.247 Meas Guidance v05r02 Procedure: The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Zero span, centered on a hopping channel. b) RBW shall be <= channel spacing and where possible RBW should be set >> 1 / T, where T is the expected dwell time per channel. c) Sweep: As necessary to capture the entire dwell time per hopping channel; where possible use a video trigger and trigger delay so that the transmitted signal starts a little to the right of the start of the plot. The trigger level might need slight adjustment to prevent triggering when the system hops on an adjacent channel; a second plot might be needed with a longer sweep time to show two successive hops on a channel. d) Detector function: Peak. e) Trace: Max hold. Use the marker-delta function to determine the transmit time per hop. If this value varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation in transmit time. Repeat the measurement using a longer sweep time to determine the number of hops over the period specified in the requirements. The sweep time shall be equal to, or less than, the period specified in the requirements, using the following equation: (Number of hops on spectrum analyzer) × (period specified in the requirements / analyzer sweep time) The average time of occupancy is calculated from the transmit time per hop multibiled by the number of hops in t	4.0 5 11011 111110	
MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used. Test Method: ANSI C63.10-2013, section 7.8.4 KDB 558074 D01 15.247 Meas Guidance v05r02 Procedure: The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Zero span, centered on a hopping channel. b) RBW shall be <= channel spacing and where possible RBW should be set >> 1 / T, where T is the expected dwell time per channel. c) Sweep: As necessary to capture the entire dwell time per hopping channel; where possible use a video trigger and trigger delay so that the transmitted signal starts a little to the right of the start of the plot. The trigger level might need slight adjustment to prevent triggering when the system hops on an adjacent channel; a second plot might be needed with a longer sweep time to show two successive hops on a channel. d) Detector function: Peak. e) Trace: Max hold. Use the marker-delta function to determine the transmit time per hop. If this value varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation in transmit time. Repeat the measurement using a longer sweep time to determine the number of hops over the period specified in the requirements. The sweep time and calculate the total number of hops in the period specified in the requirements, using the following equation: (Number of hops in the period specified in the requirements, using the following equation: (Number of hops on spectrum analyzer) × (period specified in the requirements / analyzer sweep time) The average time of occupancy is calculated from the transmit time per hop	Test Requirement:	47 CFR 15.247(a)(1)(iii)
Procedure: The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Zero span, centered on a hopping channel. b) RBW shall be <= channel spacing and where possible RBW should be set >> 1 / T, where T is the expected dwell time per channel. c) Sweep: As necessary to capture the entire dwell time per hopping channel; where possible use a video trigger and trigger delay so that the transmitted signal starts a little to the right of the start of the plot. The trigger level might need slight adjustment to prevent triggering when the system hops on an adjacent channel; a second plot might be needed with a longer sweep time to show two successive hops on a channel. d) Detector function: Peak. e) Trace: Max hold. Use the marker-delta function to determine the transmit time per hop. If this value varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation in transmit time. Repeat the measurement using a longer sweep time to determine the number of hops over the period specified in the requirements. The sweep time shall be equal to, or less than, the period specified in the requirements, using the following equation: (Number of hops in the period specified in the requirements, using the following equation: (Number of hops on spectrum analyzer) × (period specified in the requirements / analyzer sweep time) The average time of occupancy is calculated from the transmit time per hop	Test Limit:	MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency
analyzer settings: a) Span: Zero span, centered on a hopping channel. b) RBW shall be <= channel spacing and where possible RBW should be set >> 1 / T, where T is the expected dwell time per channel. c) Sweep: As necessary to capture the entire dwell time per hopping channel; where possible use a video trigger and trigger delay so that the transmitted signal starts a little to the right of the start of the plot. The trigger level might need slight adjustment to prevent triggering when the system hops on an adjacent channel; a second plot might be needed with a longer sweep time to show two successive hops on a channel. d) Detector function: Peak. e) Trace: Max hold. Use the marker-delta function to determine the transmit time per hop. If this value varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation in transmit time. Repeat the measurement using a longer sweep time to determine the number of hops over the period specified in the requirements. The sweep time shall be equal to, or less than, the period specified in the requirements, using the following equation: (Number of hops in the period specified in the requirements, using the following equation: (Number of hops on spectrum analyzer) × (period specified in the requirements / analyzer sweep time) The average time of occupancy is calculated from the transmit time per hop	Test Method:	
number of hops in a specific time varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation. The measured transmit time and time between hops shall be consistent with the values described in the operational description for the EUT.	1C	analyzer settings: a) Span: Zero span, centered on a hopping channel. b) RBW shall be <= channel spacing and where possible RBW should be set >> 1 / T, where T is the expected dwell time per channel. c) Sweep: As necessary to capture the entire dwell time per hopping channel; where possible use a video trigger and trigger delay so that the transmitted signal starts a little to the right of the start of the plot. The trigger level might need slight adjustment to prevent triggering when the system hops on an adjacent channel; a second plot might be needed with a longer sweep time to show two successive hops on a channel. d) Detector function: Peak. e) Trace: Max hold. Use the marker-delta function to determine the transmit time per hop. If this value varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation in transmit time. Repeat the measurement using a longer sweep time to determine the number of hops over the period specified in the requirements. The sweep time shall be equal to, or less than, the period specified in the requirements, using the following equation: (Number of hops in the period specified in the requirements, using the following equation: (Number of hops on spectrum analyzer) × (period specified in the requirements / analyzer sweep time) The average time of occupancy is calculated from the transmit time per hop multiplied by the number of hops in the period specified in the requirements. If the number of hops in a specific time varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation. The measured transmit time and time between hops shall be consistent with the

Report No.: DACE240829002RF001

4.6.1 E.U.T. Operation:

Operating Environment:						
Temperature:	22.3 °C		Humidity:	47 %	Atmospheric Pressure:	102 kPa
Pretest mode: TM3		TM3,	TM4			
Final test mode:		TM3,	TM4	6		

4.6.2 Test Setup Diagram:

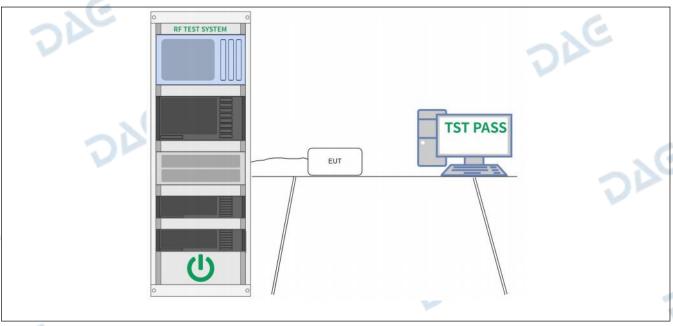
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DIE

DAG





DAG

DAG

4.6.3 Test Data:

DAG

DAG

Please Refer to Appendix for Details.

DAG

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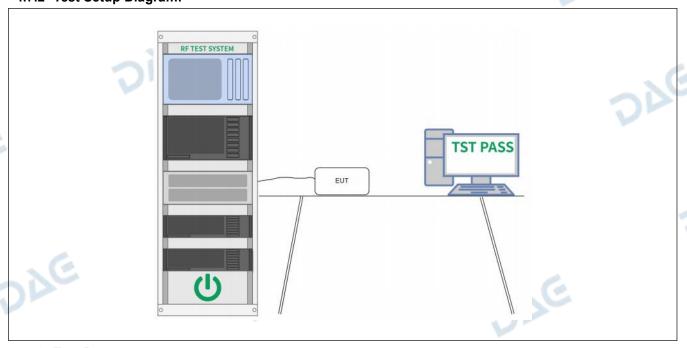
4.7 Emissions in non-restricted frequency bands

Test Requirement:	47 CFR 15.247(d), 15.209, 15.205
Test Limit:	Refer to 47 CFR 15.247(d), In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in § 15.209(a) is not required.
Test Method:	ANSI C63.10-2013 section 7.8.8 KDB 558074 D01 15.247 Meas Guidance v05r02
Procedure:	Conducted spurious emissions shall be measured for the transmit frequency, per 5.5 and 5.6, and at the maximum transmit powers. Connect the primary antenna port through an attenuator to the spectrum analyzer input; in the results, account for all losses between the unlicensed wireless device output and the spectrum analyzer. The instrument shall span 30 MHz to 10 times the operating frequency in GHz, with a resolution bandwidth of 100 kHz, video bandwidth of 300 kHz, and a coupled sweep time with a peak detector. The band 30 MHz to the highest frequency may be split into smaller spans, as long as the entire spectrum is covered.

4.7.1 E.U.T. Operation:

Operating Environment:						
Temperature: 22.3 °C		Humidity:	47 %		Atmospheric Pressure:	102 kPa
Pretest mode:	etest mode: TM1, TM2, TM3, TM4			C		. 6
Final test mode:	TM1,	TM2, TM3, 7	ГМ4			

4.7.2 Test Setup Diagram:



4.7.3 Test Data:

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4.8 Band edge emissions (Radiated)

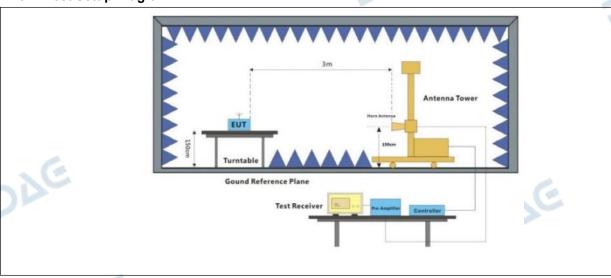
V1.0

Test Requirement:	Refer to 47 CFR 15.247(d), In addition, radiated emissions which fall in the restricted bands, as defined in § 15.205(a), must also comply with the radiated emission limits specified in § 15.209(a)(see § 15.205(c)).`						
Test Limit:	Frequency (MHz)	Field strength (microvolts/meter)	Measurement distance (meters)				
	0.009-0.490	2400/F(kHz)	300				
	0.490-1.705	24000/F(kHz)	30				
	1.705-30.0	30	30				
	30-88	100 **	3				
	88-216	150 **	3				
	216-960	200 **	3				
4	Above 960	500	3				
VC.	** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§ 15.231 and 15.241. In the emission table above, the tighter limit applies at the band edges. The emission limits shown in the above table are based on measurements employing a CISPR quasi-peak detector except for the frequency bands 9–90 kHz, 110–490 kHz and above 1000 MHz. Radiated emission limits in these three bands						
T. AMAGE AL	are based on measurements employing an average detector.						
Test Method:	ANSI C63.10-2013 secti KDB 558074 D01 15.24	on 6.10 7 Meas Guidance v05r02					
Procedure:	ANSI C63.10-2013 secti	on 6.10.5.2	16				

4.8.1 E.U.T. Operation:

Operating Environment:							
Temperature:	-	Humidity:	47 %	Atmospheric Pressure:	102 kPa		
Pretest mode: TM1,			TM2		. 6		
Final test mode: TM1							

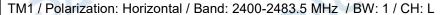
4.8.2 Test Setup Diagram:

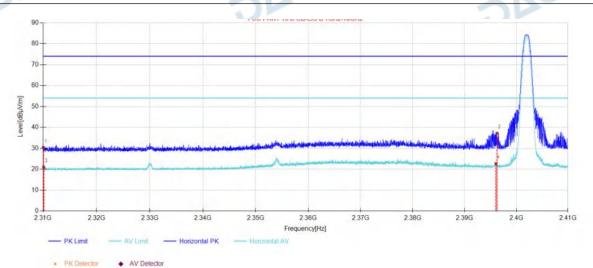


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4.8.3 Test Data:

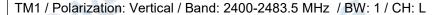


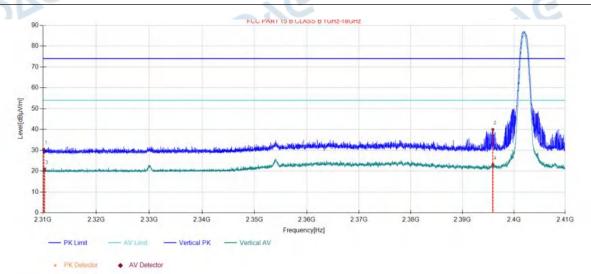


Report No.: DACE240829002RF001

Susp	ected Data	List						
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	2310.07	30.36	-11.73	74.00	43.64	150	2	Horizontal
2	2396.26	37.18	-11.45	74.00	36.82	150	169	Horizontal
3	2310.12	20.97	-11.73	54.00	33.03	150	356	Horizontal
4	2396.03	22.66	-11.46	54.00	31.34	150	151	Horizontal

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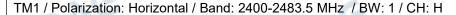


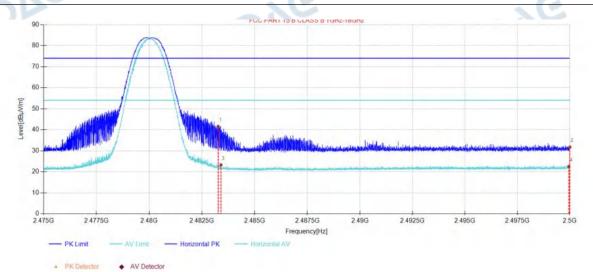
Susp	Suspected Data List											
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity				
1	2310.15	30.42	-11.73	74.00	43.58	150	273	Vertical				
2	2395.89	39.96	-11.46	74.00	34.04	150	102	Vertical				
3	2310.31	21.03	-11.73	54.00	32.97	150	173	Vertical				
4	2395.91	23.13	-11.46	54.00	30.87	150	108	Vertical				

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DAG







Susp	Suspected Data List											
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity				
1	2483.26	41.60	-11.18	74.00	32.40	150	147	Horizontal				
2	2500	31.76	-11.12	74.00	42.24	150	360	Horizontal				
3	2483.39	23.27	-11.18	54.00	30.73	150	135	Horizontal				
4	2499.95	22.54	-11.12	54.00	31.46	150	330	Horizontal				

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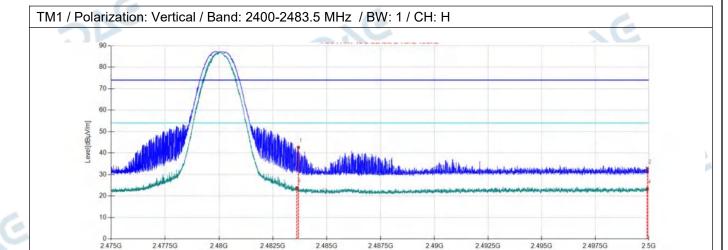
DAG



DAG

V1.0

PK Detector



Suspected Data List Level Factor Limit Freq. Margin Height Angle NO. Polarity [MHz] [dBµV/m] [dB] [dBµV/m] [dB] [°] [cm] 2483.67 42.63 -11.1874.00 31.37 150 76 Vertical 1 2 2499.93 32.73 -11.1274.00 41.27 150 110 Vertical 2483.60 23.79 -11.18 54.00 30.21 150 76 Vertical 3 2499.92 -11.12 54.00 30.61 150 81 Vertical 23.39

Frequency[Hz]

- Vertical PK

AV Detector

Remark: Both left and right ears have been tested, and only the worst left ear data is reflected in the report.

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DAG



4.9 Emissions in frequency bands (below 1GHz)

Test Requirement:		(d), In addition, radiated emissions ned in § 15.205(a), must also com						
		in § 15.209(a)(see § 15.205(c)).`	pry with the radiated					
Test Limit:	Frequency (MHz)	Field strength (microvolts/meter)	Measurement distance (meters)					
	0.009-0.490	2400/F(kHz)	300					
	0.490-1.705	24000/F(kHz)	30					
	1.705-30.0	30	30					
	30-88	100 **	3					
	88-216	150 **	3					
	216-960	200 **	3					
	Above 960	500	3					
		paragraph (g), fundamental emiss r this section shall not be located						
	these frequency bands is and 15.241. In the emission table about The emission limits show employing a CISPR quant 110–490 kHz and above	174-216 MHz or 470-806 MHz. He is permitted under other sections of ove, the tighter limit applies at the vn in the above table are based or si-peak detector except for the free 1000 MHz. Radiated emission limitents employing an average detection.	f this part, e.g., §§ 15.23 band edges. n measurements quency bands 9–90 kHz, nits in these three bands					
Test Method:	ANSI C63.10-2013 secti KDB 558074 D01 15.247	on 6.6.4 7 Meas Guidance v05r02	_					
Procedure:	above the ground at a 3 360 degrees to determin b. For above 1GHz, the above the ground at a 3 degrees to determine the c. The EUT was set 3 or	EUT was placed on the top of a ro or 10 meter semi-anechoic chamble the position of the highest radial EUT was placed on the top of a rometer fully-anechoic chamber. The position of the highest radiation. 10 meters away from the interference top of a variable-height antennal	per. The table was rotated tion. stating table 1.5 meters e table was rotated 360 ence-receiving antenna,					
	determine the maximum polarizations of the anter e. For each suspected e the antenna was tuned to below 30MHz, the anten was turned from 0 degree f. The test-receiver system Bandwidth with Maximur g. If the emission level or	varied from one meter to four meter value of the field strength. Both he may are set to make the measurent mission, the EUT was arranged to be heights from 1 meter to 4 meters na was tuned to heights 1 meter) set to 360 degrees to find the maxem was set to Peak Detect Function Hold Mode. If the EUT in peak mode was 10dE and be stopped and the peak value.	orizontal and vertical ment. is its worst case and then is (for the test frequency cand the rotatable table imum reading. In and Specified					
	reported. Otherwise the emissions that did not have 10dB margin would be retested one by one using peak, quasi-peak or average method as specified and then reported in a data sheet. h. Test the EUT in the lowest channel, the middle channel, the Highest channel. i. The radiation measurements are performed in X, Y, Z axis positioning for Transmitting mode, and found the X axis positioning which it is the worst case. j. Repeat above procedures until all frequencies measured was complete. Remark: 1) For emission below 1GHz, through pre-scan found the worst case is the lowest							

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channel. Only the worst case is recorded in the report.

2) The field strength is calculated by adding the Antenna Factor, Cable Factor & Preamplifier. The basic equation with a sample calculation is as follows: Final Test Level =Receiver Reading + Antenna Factor + Cable Factor "C Preamplifier Factor

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3) Scan from 9kHz to 25GHz, the disturbance above 12.75GHz and below 30MHz was very low. The points marked on above plots are the highest emissions could be found when testing, so only above points had been displayed. The amplitude of spurious emissions from the radiator which are attenuated more than 20dB below the limit need not be reported. Fundamental frequency is blocked by filter, and only spurious emission is shown.

4.9.1 E.U.T. Operation:

Operating Environment	onment:						
Temperature:	22.3 °C	_ >	Humidity:	47 %	Atmospheric Pressure:	102 kPa	
Pretest mode:		TM1,	TM2		. 6		
Final test mode: TM1, TM2							

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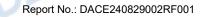
DAC

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No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Azimuth (deg.)	P/F	Remark
1	298.2681	30.32	0.60	30.92	46.00	-15.08	QP	100		Р	
2 *	374.6225	37.88	1.58	39.46	46.00	-6.54	QP	100		Р	
3	404.6665	34.80	1.36	36.16	46.00	-9.84	QP	100		Р	
4	441.7426	31.61	1.17	32.78	46.00	-13.22	QP	100		Р	
5	473.8347	29.03	1.49	30.52	46.00	-15.48	QP	100		Р	
6	955.4381	24.05	9.26	33.31	46.00	-12.69	QP	100		Р	

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TM1 / Polarization: Vertical / Band: 2400-2483.5 MHz / BW: 1 / CH: L



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Azimuth (deg.)	P/F	Remark	
1	58.8185	36.96	-9.11	27.85	40.00	-12.15	QP	100		Р		
2 *	81.7833	41.32	-7.40	33.92	40.00	-6.08	QP	100		Р		
3	304.6099	31.19	-0.03	31.16	46.00	-14.84	QP	100		Р		
4	383.9318	33.29	1.18	34.47	46.00	-11.53	QP	100		Р		
5	558.7302	27.69	3.07	30.76	46.00	-15.24	QP	100		Р		
6	955.4381	23.69	9.21	32.90	46.00	-13.10	QP	100		Р		

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4.10 Emissions in frequency bands (above 1GHz)

Test Requirement:	In addition, radiated emiss	ions which fall in the restricted ba	ands, as defined in §					
	15.205(a), must also comp 15.209(a)(see § 15.205(c))	ly with the radiated emission limi .`	ts specified in §					
Test Limit:	Frequency (MHz)	Field strength (microvolts/meter)	Measurement distance (meters)					
	0.009-0.490	2400/F(kHz)	300					
	0.490-1.705	24000/F(kHz)	30					
	1.705-30.0	30	30					
	30-88	100 **	3					
	88-216	150 **	3					
	216-960	200 **	3					
	Above 960	500	3					
	The emission limits shown employing a CISPR quasi-110–490 kHz and above 10	e, the tighter limit applies at the b in the above table are based on peak detector except for the freq 000 MHz. Radiated emission limi its employing an average detector	measurements uency bands 9–90 kHz, ts in these three bands					
Test Method:	ANSI C63.10-2013 section KDB 558074 D01 15.247 M	6.6.4						
Procedure:	a. For below 1GHz, the EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 or 10 meter semi-anechoic chamber. The table was rotal 360 degrees to determine the position of the highest radiation. b. For above 1GHz, the EUT was placed on the top of a rotating table 1.5 meters above the ground at a 3 meter fully-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation. c. The EUT was set 3 or 10 meters away from the interference-receiving antennal which was mounted on the top of a variable-height antennal tower. d. The antenna height is varied from one meter to four meters above the ground determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antennal are set to make the measurement. e. For each suspected emission, the EUT was arranged to its worst case and the the antennal was tuned to heights from 1 meter to 4 meters (for the test frequency below 30MHz, the antennal was tuned to heights 1 meter) and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading. f. The test-receiver system was set to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode. g. If the emission level of the EUT in peak mode was 10dB lower than the limit specified, then testing could be stopped and the peak values of the EUT would be reported. Otherwise the emissions that did not have 10dB margin would be retested one by one using peak, quasi-peak or average method as specified and the reported in a data sheet. h. Test the EUT in the lowest channel, the middle channel, the Highest channel.							
	Remark:	s until all frequencies measured dz, through pre-scan found the w	·					

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channel. Only the worst case is recorded in the report.

2) The field strength is calculated by adding the Antenna Factor, Cable Factor & Preamplifier. The basic equation with a sample calculation is as follows: Final Test Level =Receiver Reading + Antenna Factor + Cable Factor "C Preamplifier Factor

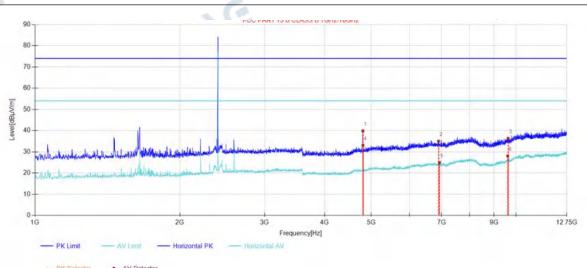
3) Scan from 9kHz to 25GHz, the disturbance above 12.75GHz and below 30MHz was very low. The points marked on above plots are the highest emissions could be found when testing, so only above points had been displayed. The amplitude of spurious emissions from the radiator which are attenuated more than 20dB below the limit need not be reported. Fundamental frequency is blocked by filter, and only spurious emission is shown.

4.10.1 E.U.T. Operation:

Operating Envir	onment:					
Temperature:	22.3 °C	- >	Humidity:	47 %	Atmospheric Pressure:	102 kPa
Pretest mode:		TM1,	TM2		. 6	
Final test mode:		TM1			270	

4.10.2Test Data:

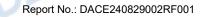
TM1 / Polarization: Horizontal / Band: 2400-2483.5 MHz / BW: 1 / CH: L



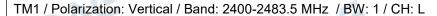
Susp	Suspected Data List											
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity				
1	4804.53	39.86	-6.94	74.00	34.14	150	320	Horizontal				
2	6900.70	35.01	-3.17	74.00	38.99	150	125	Horizontal				
3	9628.51	36.32	0.81	74.00	37.68	150	114	Horizontal				
4	4806.00	33.07	-6.94	54.00	20.93	150	119	Horizontal				
5	6933.02	24.90	-3.15	54.00	29.10	150	136	Horizontal				
6	9609.41	28.04	0.75	54.00	25.96	150	193	Horizontal				

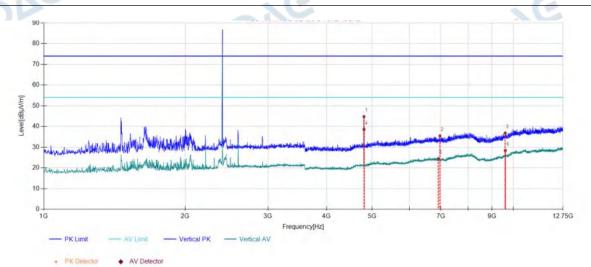
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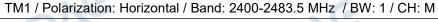


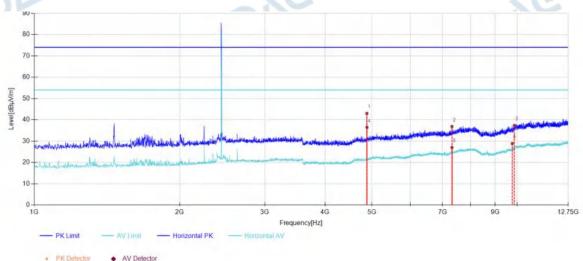


Susp	ected Data	List)-					
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	4804.53	44.75	-6.94	74.00	29.25	150	111	Vertical
2	6974.15	35.47	-3.10	74.00	38.53	150	246	Vertical
3	9607.95	36.85	0.75	74.00	37.15	150	49	Vertical
4	4806.00	38.58	-6.94	54.00	15.42	150	111	Vertical
5	6916.86	24.47	-3.16	54.00	29.53	150	235	Vertical
6	9609.41	28.40	0.75	54.00	25.60	150	49	Vertical

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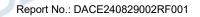




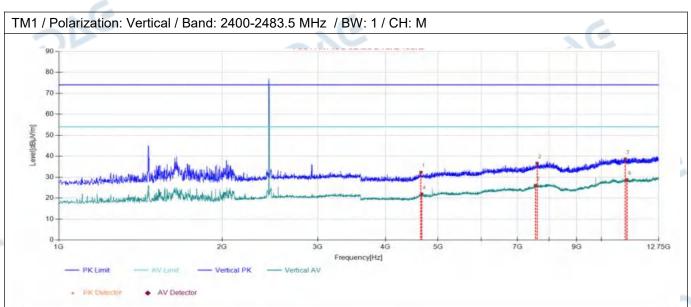


Susp	ected Data	List						
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	4882.39	43.01	-6.65	74.00	30.99	150	149	Horizontal
2	7323.75	36.87	-2.18	74.00	37.13	150	138	Horizontal
3	9865.01	37.41	1.53	74.00	36.59	150	244	Horizontal
4	4883.86	36.47	-6.65	54.00	17.53	150	144	Horizontal
5	7325.22	27.00	-2.17	54.00	27.00	150	132	Horizontal
6	9765.12	28.89	1.23	54.00	25.11	150	200	Horizontal

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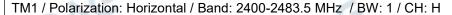


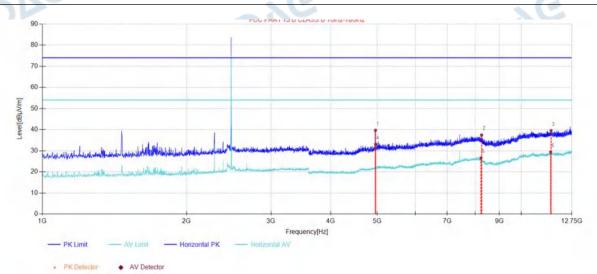
Suspected Data List								
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	4881.24	43.17	-6.65	74.00	30.83	150	164	Vertical
2	7321.21	36.24	-2.18	74.00	37.76	150	131	Vertical
3	9864.15	37.48	1.53	74.00	36.52	150	284	Vertical
4	4882.65	36.21	-6.65	54.00	17.79	150	157	Vertical
5	7324.25	27.24	-2.17	54.00	26.76	150	134	Vertical
6	9761.25	28.14	1.23	54.00	25.86	150	220	Vertical

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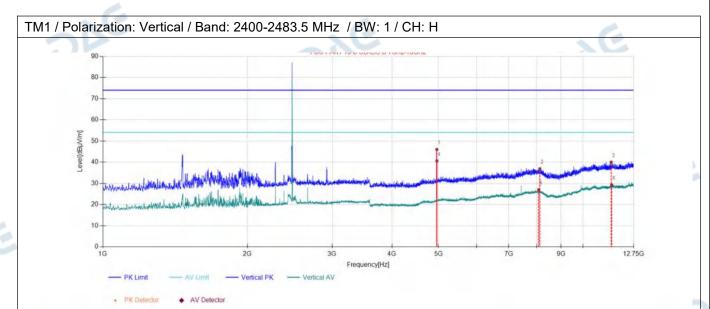


Suspe	ected Data	List						
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	4960.24	39.67	-6.36	74.00	34.33	150	139	Horizontal
2	8260.93	37.46	-0.44	74.00	36.54	150	273	Horizontal
3	11539.5	39.52	3.50	74.00	34.48	150	33	Horizontal
4	4961.71	33.04	-6.35	54.00	20.96	150	324	Horizontal
5	8234.49	26.56	-0.39	54.00	27.44	150	357	Horizontal
6	11514.6	29.36	3.54	54.00	24.64	150	110	Horizontal

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V1.0



Susp	ected Data	List						
NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	4960.24	46.03	-6.36	74.00	27.97	150	76	Vertical
2	8130.20	36.89	-0.19	74.00	37.11	150	282	Vertical
3	11444.1	40.00	3.55	74.00	34.00	150	163	Vertical
4	4961.71	40.63	-6.35	54.00	13.37	150	76	Vertical
5	8084.66	26.98	-0.09	54.00	27.02	150	288	Vertical
6	11467.6	29.26	3.55	54.00	24.74	150	30	Vertical

Remark: Both left and right ears have been tested, and only the worst left ear data is reflected in the report

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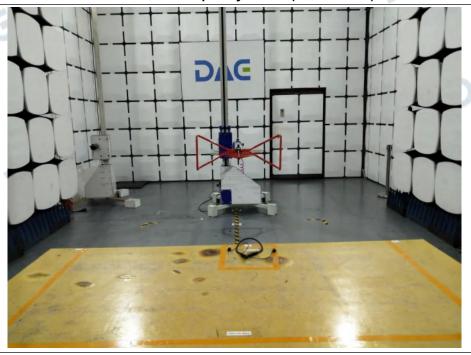


5 TEST SETUP PHOTOS

Conducted Emission at AC power line



Emissions in frequency bands (below 1GHz)



Emissions in frequency bands (above 1GHz)

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6 PHOTOS OF THE EUT

External





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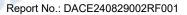
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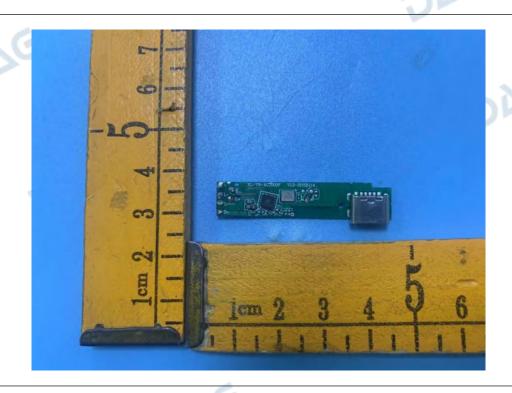






Internal





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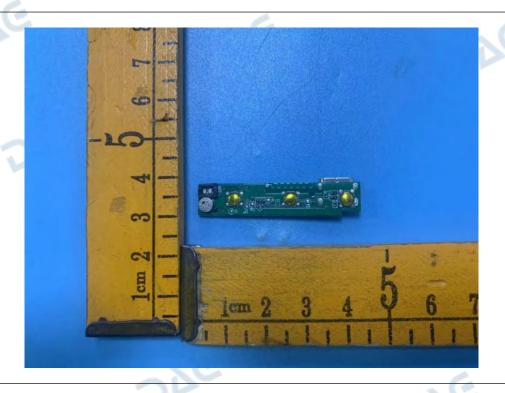
E-mail: service@dace-lab.com

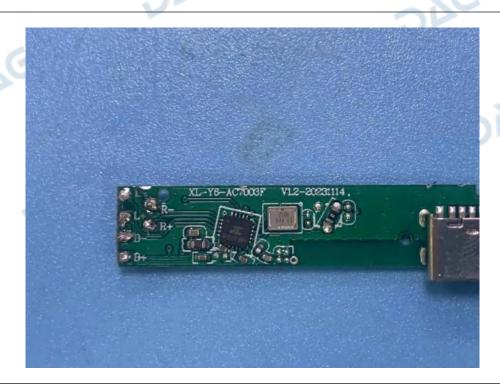
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102, Building H1, & 1/F., Building H, Hongfa Science & Technology Park, Tangtou Connunity, Shiyan Subdistrict, Bao'an District, Shenzhen, Guangdong, China



V1.0





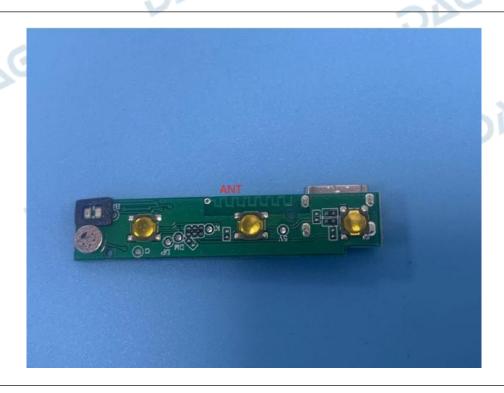
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V1.0







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DAG

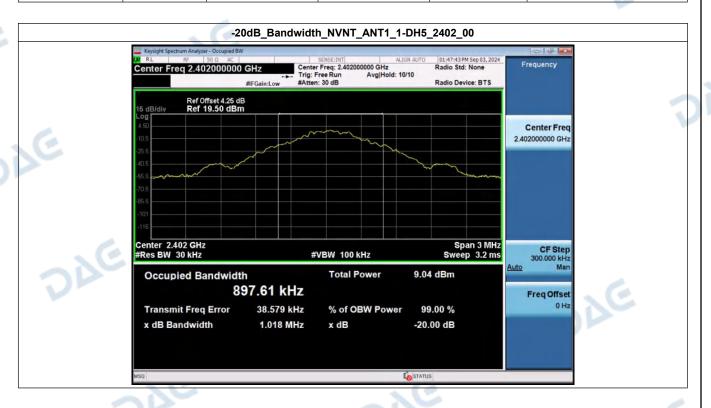


FCC_BT (Part15.247) Test Data

1. -20dB Bandwidth

V1.0

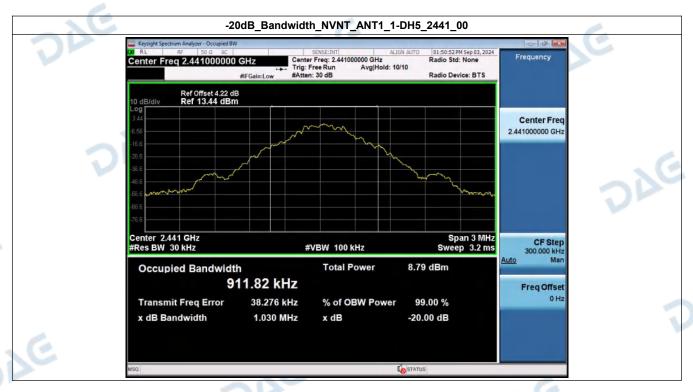
Condition	Antenna	Modulation	Frequency (MHz)	-20dB BW(MHz)	if larger than CFS
NVNT	ANT1	1-DH5	2402.00	1.018	Yes
NVNT	ANT1	1-DH5	2441.00	1.030	Yes
NVNT	ANT1	1-DH5	2480.00	1.033	Yes
NVNT	ANT1	2-DH5	2402.00	1.024	Yes
NVNT	ANT1	2-DH5	2441.00	1.030	Yes
NVNT	ANT1	2-DH5	2480.00	1.033	Yes

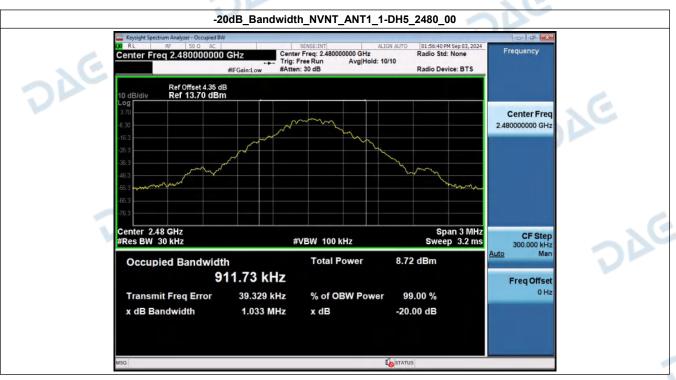


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V1.0

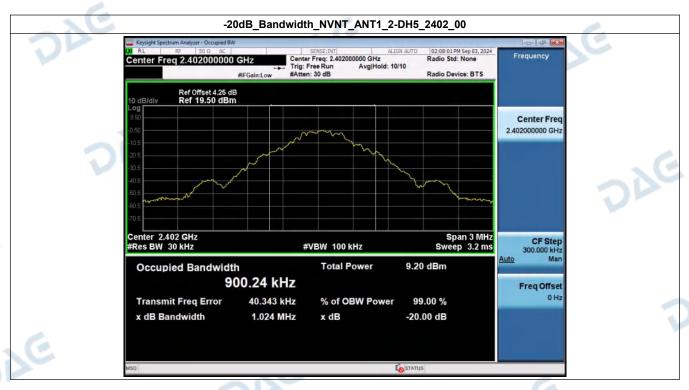


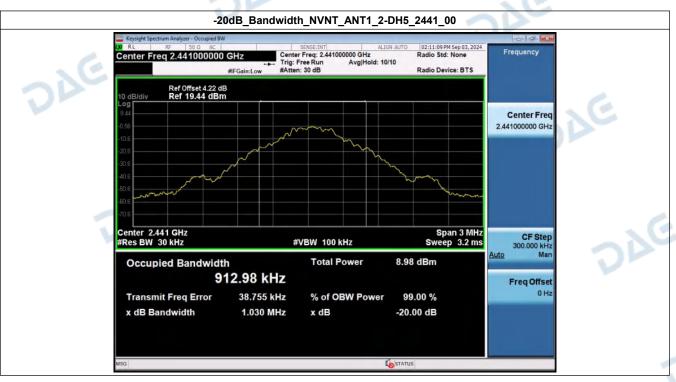


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V1.0





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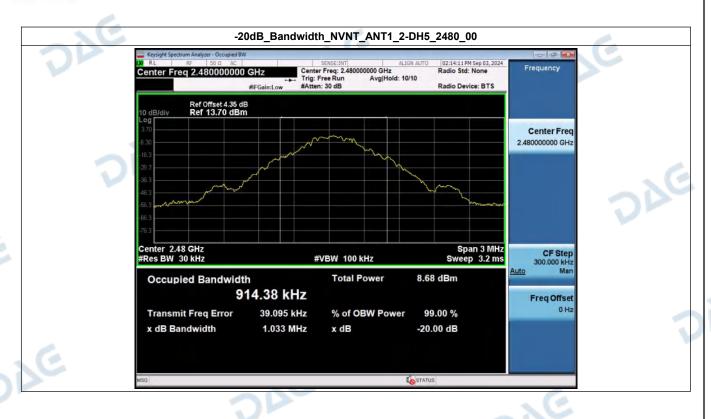


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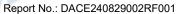
V1.0



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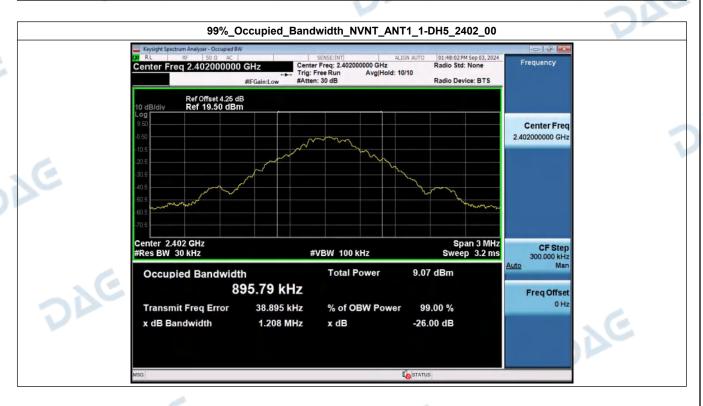
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2. 99% Occupied Bandwidth

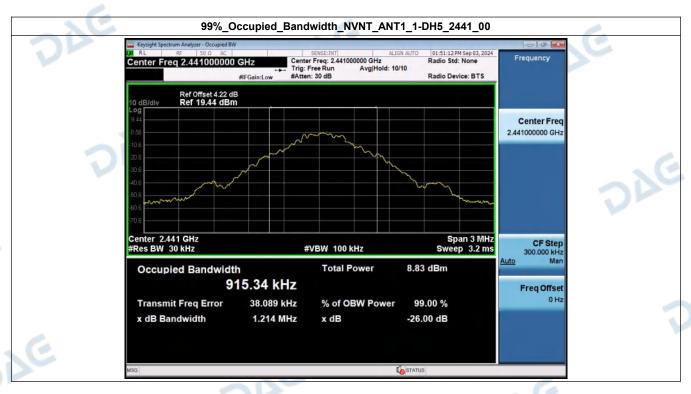
Condition	Antenna	Modulation	Frequency (MHz)	99%%BW(MHz)
NVNT	ANT1	1-DH5	2402.00	0.896
NVNT	ANT1	1-DH5	2441.00	0.915
NVNT	ANT1	1-DH5	2480.00	0.910
NVNT	ANT1	2-DH5	2402.00	0.900
NVNT	ANT1	2-DH5	2441.00	0.914
NVNT	ANT1	2-DH5	2480.00	0.912

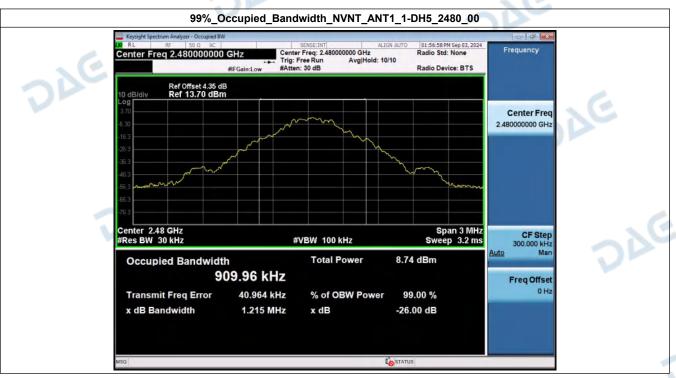


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V1.0

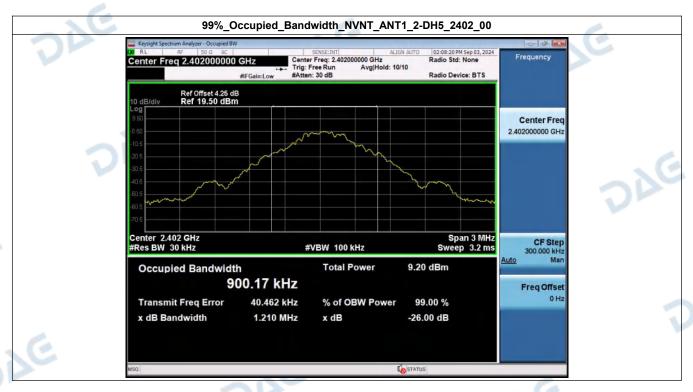


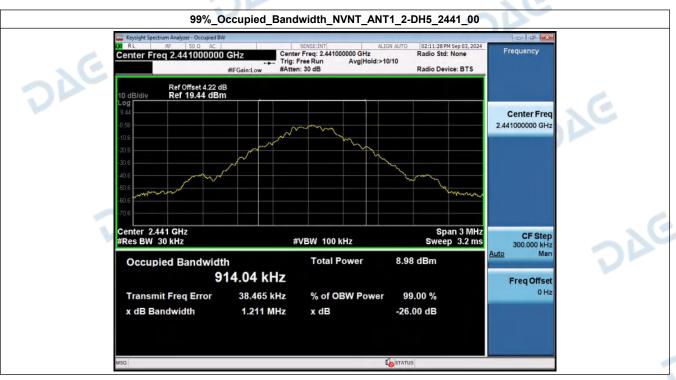


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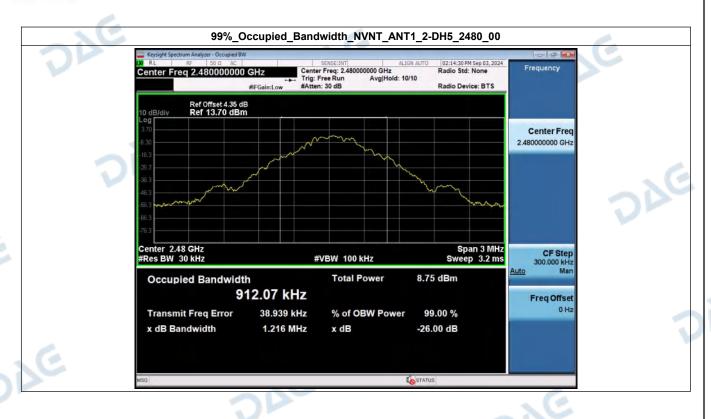


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V1.0



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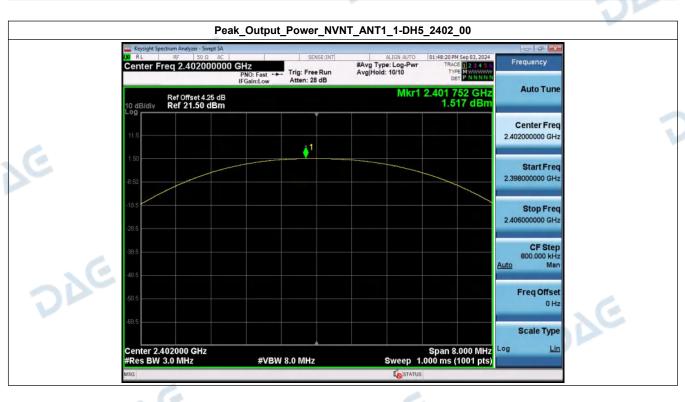
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3. Peak Output Power

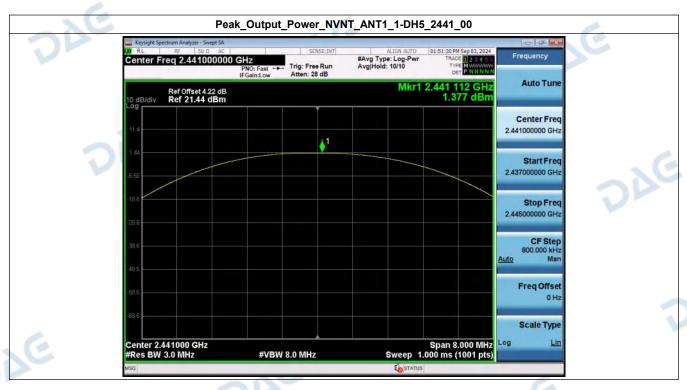
Condition	Antenna	Modulation	Frequency (MHz)	Max. Conducted Power(dBm)	Max. Conducted Power(mW)	Limit(mW)	Result
NVNT	ANT1	1-DH5	2402.00	1.52	1.42	125	Pass
NVNT	ANT1	1-DH5	2441.00	1.38	1.37	125	Pass
NVNT	ANT1	1-DH5	2480.00	1.18	1.31	125	Pass
NVNT	ANT1	2-DH5	2402.00	1.70	1.48	125	Pass
NVNT	ANT1	2-DH5	2441.00	1.47	1.40	125	Pass
NVNT	ANT1	2-DH5	2480.00	1.21	1.32	125	Pass

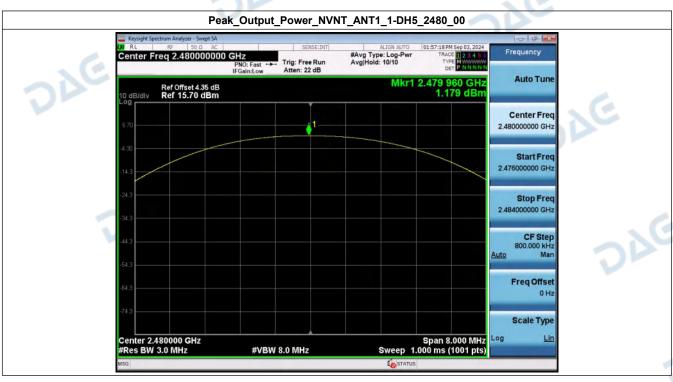


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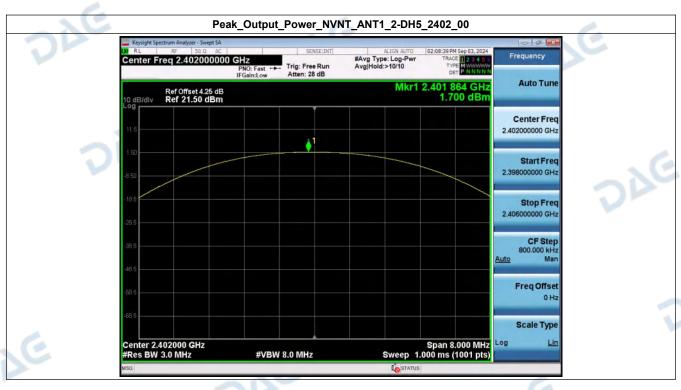
DAG

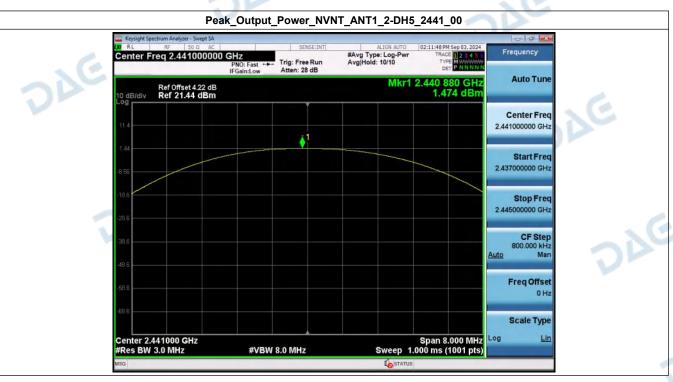






DAG



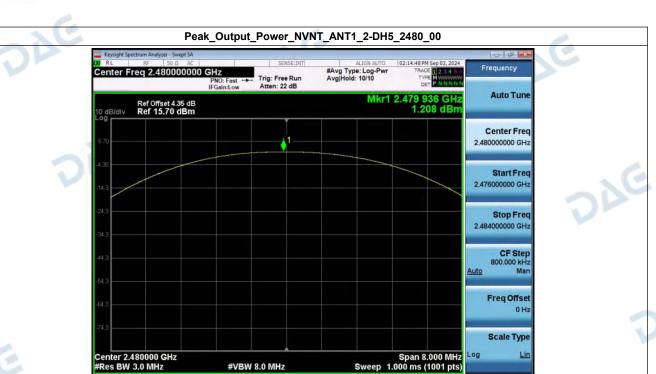




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Report No.: DACE240829002RF001

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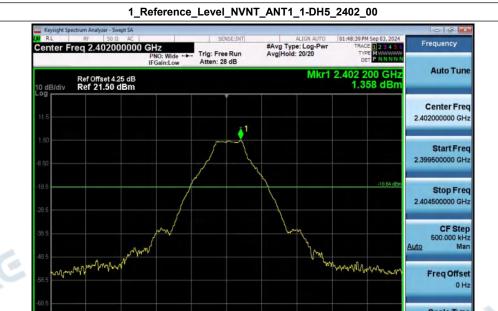
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4. Spurious Emissions

Center 2.402000 GHz #Res BW 100 kHz

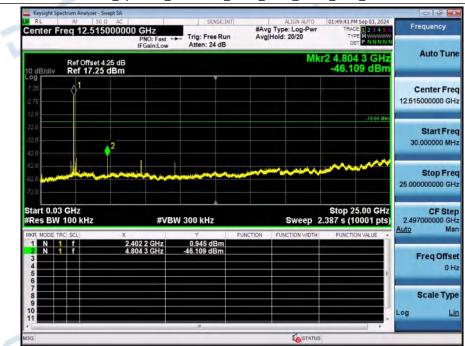
Condition	Antenna	Modulation	TX Mode	TX Mode Spurious MAX.Value(dBm)		Result
NVNT	ANT1	1-DH5	2402.00	-46.109	-18.642	Pass
NVNT	ANT1	1-DH5	2441.00	-47.510	-18.919	Pass
NVNT	ANT1	1-DH5	2480.00	-46.414	-19.046	Pass
NVNT	ANT1	2-DH5	2402.00	-45.865	-18.459	Pass
NVNT	ANT1	2-DH5	2441.00	-45.872	-18.722	Pass
NVNT	ANT1	2-DH5	2480.00	-46.993	-19.060	Pass



2 Spurious Emissions NVNT ANT1 1-DH5 2402 00

#VBW 300 kHz

Span 5.000 MHz Sweep 1.000 ms (1001 pts)



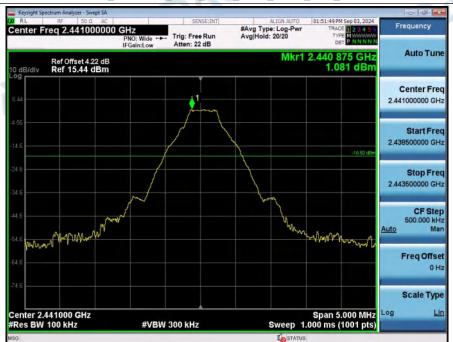
102, Building H1, & 1/F., Building H, Hongfa Science & Technology Park, Tangtou Connunity, Shiyan Subdistrict, Bao'an District, Shenzhen, Guangdong, China

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DAG

V1.0





2_Spurious_Emissions_NVNT_ANT1_1-DH5_2441_00



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DAG



V1.0





2_Spurious_Emissions_NVNT_ANT1_1-DH5_2480_00



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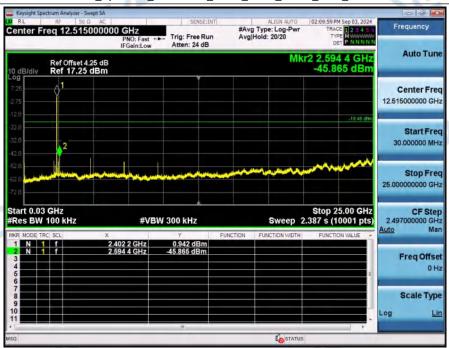
V1.0



Report No.: DACE240829002RF001



2_Spurious_Emissions_NVNT_ANT1_2-DH5_2402_00



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DAG



V1.0





2_Spurious_Emissions_NVNT_ANT1_2-DH5_2441_00

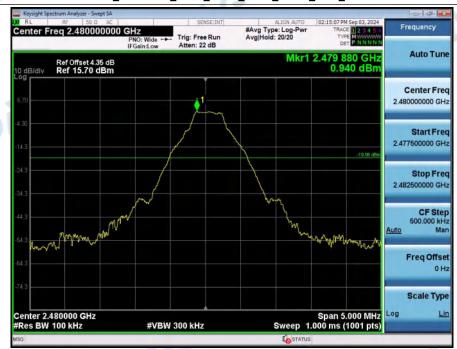


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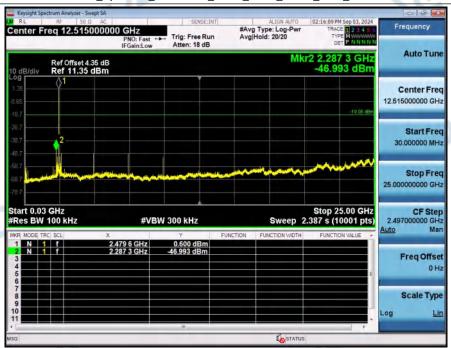


V1.0

1_Reference_Level_NVNT_ANT1_2-DH5_2480_00



2_Spurious_Emissions_NVNT_ANT1_2-DH5_2480_00



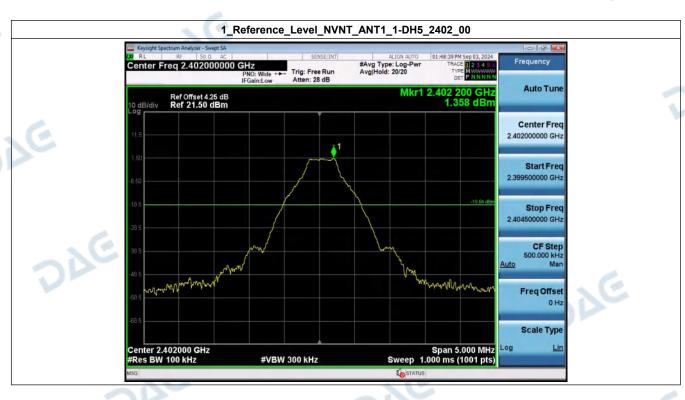
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DAG



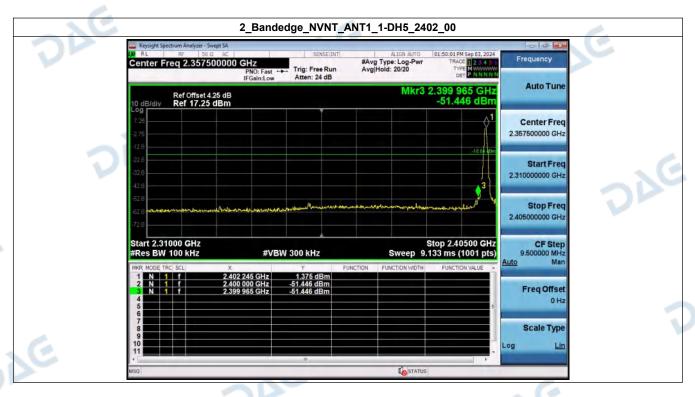
Banded	ge						
Condition	Antenna	Modulation	TX Mode	Bandedge MAX.Value	Limit	Result	
NVNT	ANT1	1-DH5	2402.00	-51.446	-18.642	Pass	
NVNT	ANT1	1-DH5	Hopping_LCH	-55.674	-18.356	Pass	
NVNT	ANT1	1-DH5	2480.00	-60.404	-19.046	Pass	
NVNT	ANT1	1-DH5	Hopping_HCH	-48.884	-18.202	Pass	
NVNT	ANT1	2-DH5	2402.00	-51.283	-18.459	Pass	
NVNT	ANT1	2-DH5	Hopping_LCH	-54.761	-18.380	Pass	
NVNT	ANT1	2-DH5	2480.00	-60.356	-19.060	Pass	
NVNT	ANT1	2-DH5	Hopping_HCH	-48.271	-18.272	Pass	

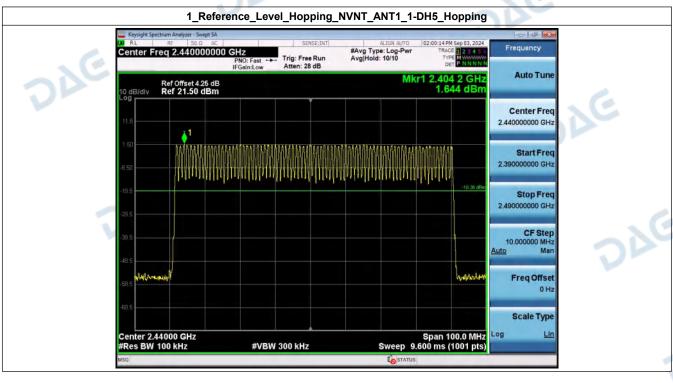
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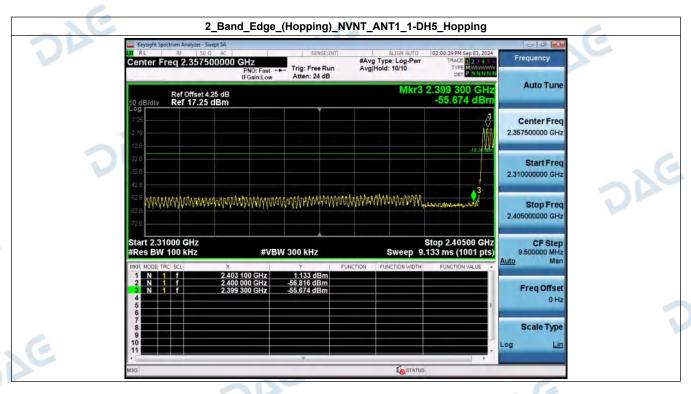






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V1.0

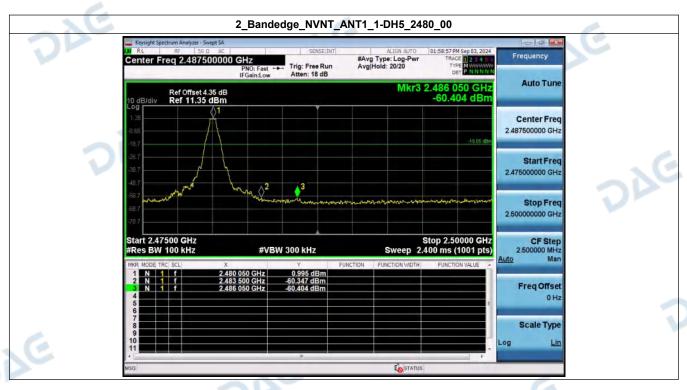


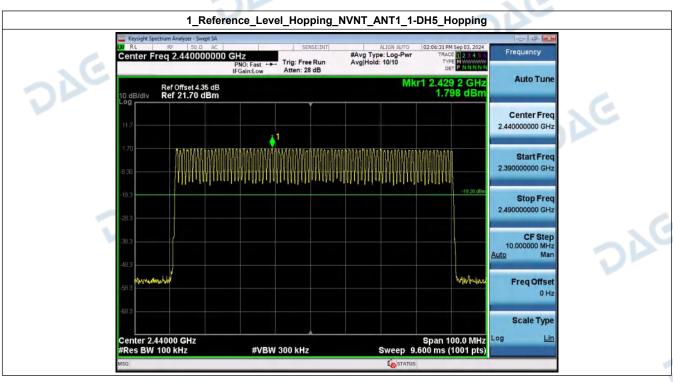


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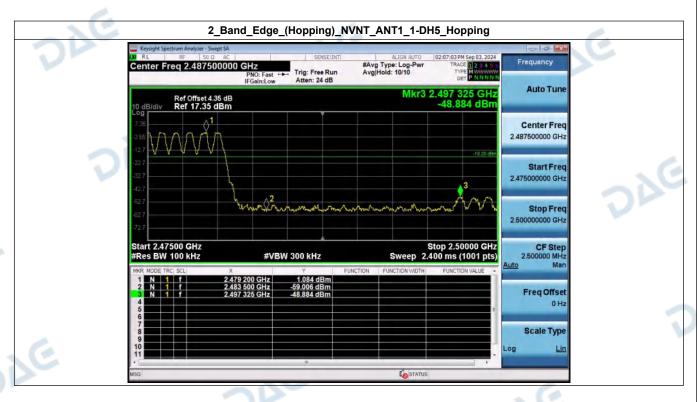
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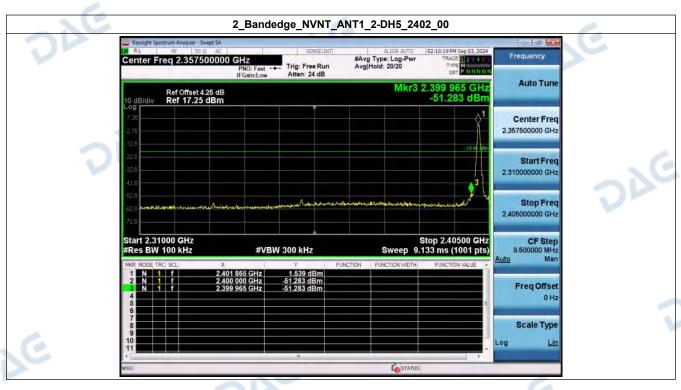
DAG

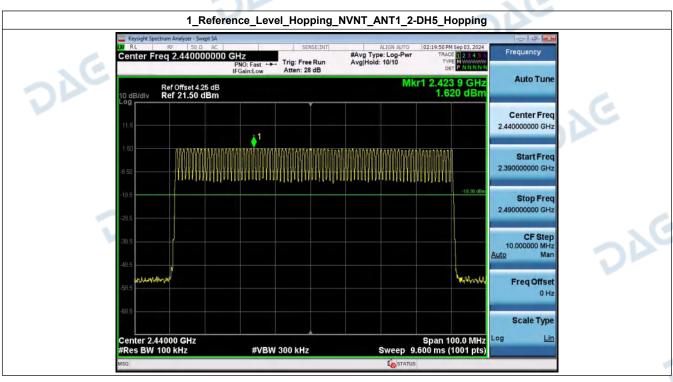






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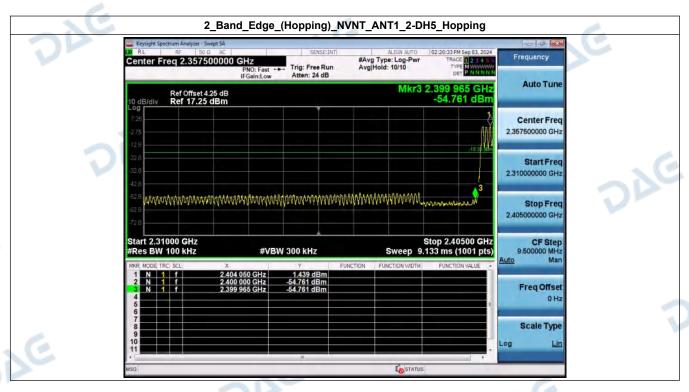






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V1.0

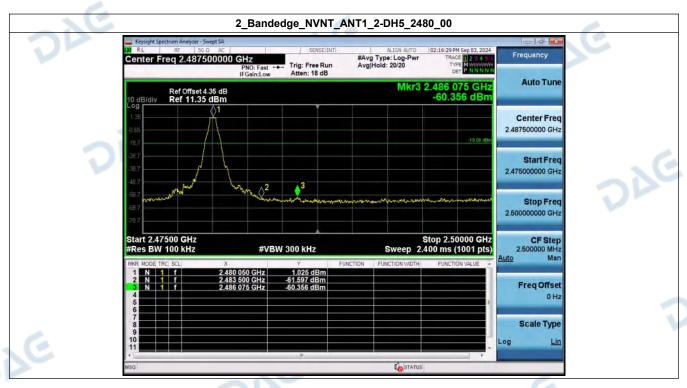


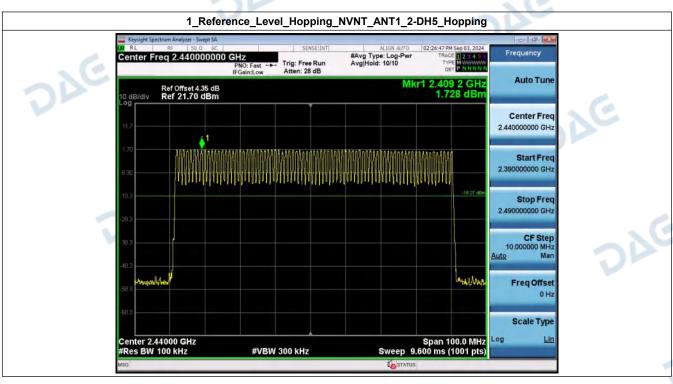


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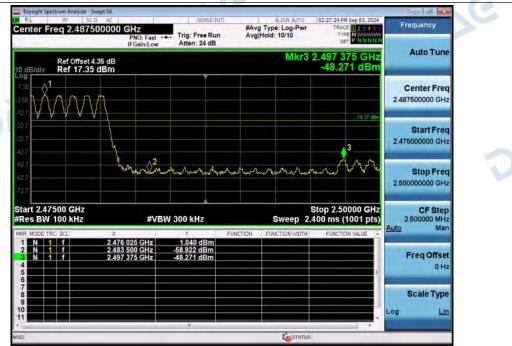
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Report No.: DACE240829002RF001



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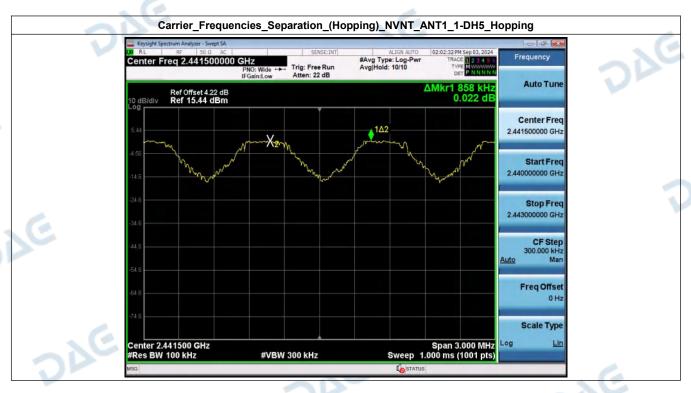
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6. Carrier Frequencies Separation (Hopping)

V1.0

Condition	Antenna	Modulation	Frequency(MHz)	Hopping NO.0 (MHz)	Hopping NO.1 (MHz)	Carrier Frequencies Separation(MHz)	Limit(MHz)	Result
NVNT	ANT1	1-DH5	2441.00	2441.080	2441.938	0.86	0.687	Pass
NVNT	ANT1	2-DH5	2441.00	2441.038	2441.881	0.84	0.687	Pass



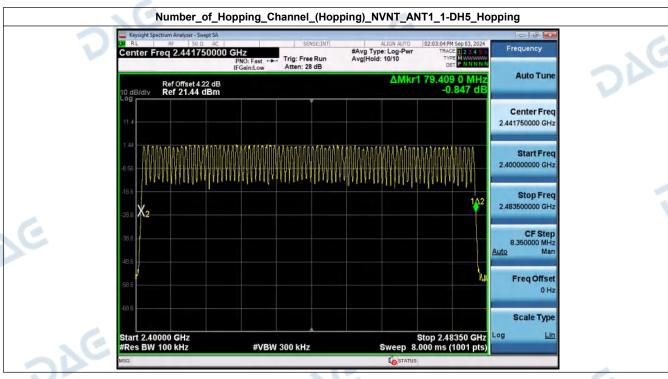


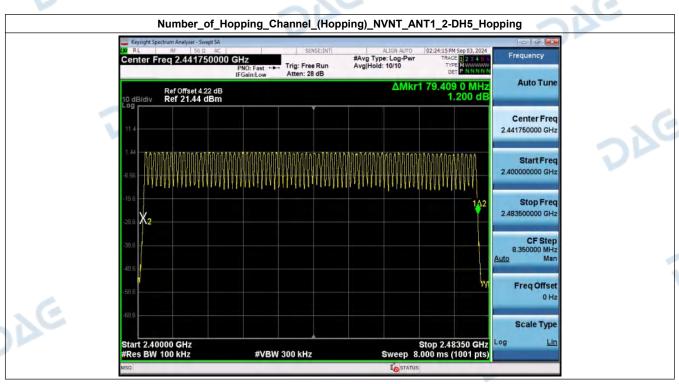
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7. Number of Hopping Channel (Hopping)

Condition	Antenna	Modulation	Hopping Num	Limit	Result
NVNT	ANT1	1-DH5	79	15	Pass
NVNT	ANT1	2-DH5	79	15	Pass



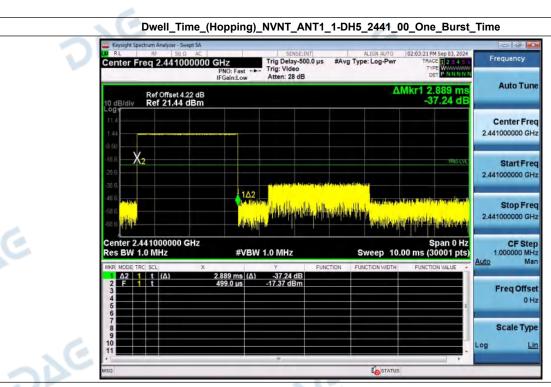




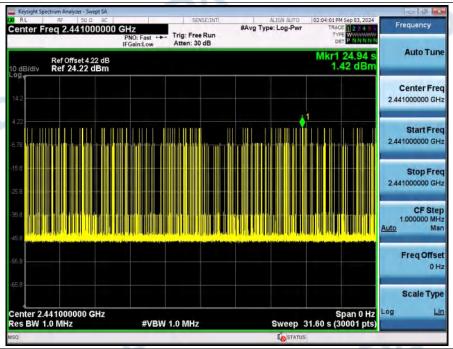
8. Dwell Time (Hopping)

V1.0

Condition	Antenna	Packet Type	Pulse Time(ms)	Hops	Dwell Time(ms)	Limit(s)	Result
NVNT	ANT1	1-DH5	2.889	99.00	286.011	0.40	Pass
NVNT	ANT1	2-DH5	2.889	105.00	303.345	0.40	Pass

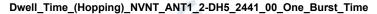


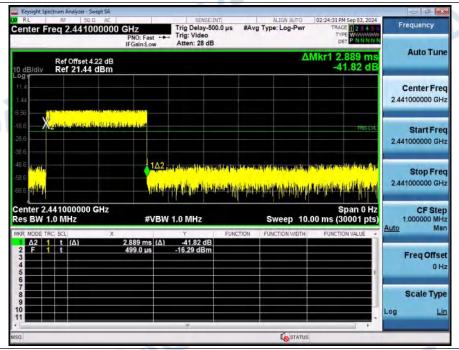
Dwell_Time_(Hopping)_NVNT_ANT1_1-DH5_2441_00_Accumulated



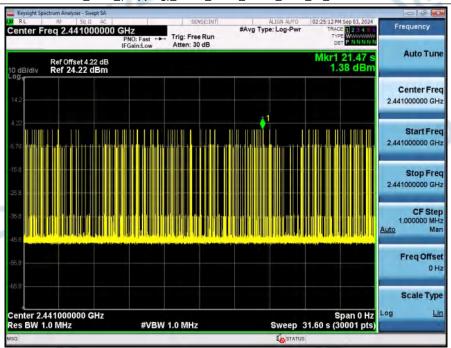
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Dwell_Time_(Hopping)_NVNT_ANT1_2-DH5_2441_00_Accumulated



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